N-Channel UniFET MOSFET

200 V, 52 A, 49 m Ω

Description

UniFET MOSFET is ON Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.

Features

- $R_{DS(on)} = 41 \text{ m}\Omega$ (Typ.) @ $V_{GS} = 10 \text{ V}, I_D = 26 \text{ A}$
- Low Gate Charge (Typ. 49 nC)
- Low C_{RSS} (Typ. 66 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

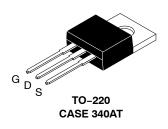
Applications

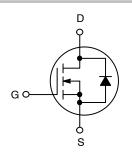
- PDP TV
- Lighting
- Uninterruptible Power Supply
- AC-DC Power Supply



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ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

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| Symbol | Parameter | | Value | Unit |
|----------------------|--|-------------------------------------|-------------|------|
| V _{DSS} | Drain to Source Voltage | | 200 | V |
| V _{GSS} | Gate to Source Voltage | | ±30 | V |
| Ι _D | Drain Current | Continuous (T _C = 25°C) | 52 | А |
| | | Continuous (T _C = 100°C) | 33 | |
| I _{DM} | Drain Current | Pulsed (Note 1) | 208 | А |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | | 2520 | mJ |
| I _{AR} | Avalanche Current (Note 1) | | 52 | А |
| E _{AR} | Repetitive Avalanche Energy (Note 1) | | 35.7 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | | 4.5 | V/ns |
| P _D | Power Dissipation | (T _C = 25°C) | 357 | W |
| | | Derate Above 25°C | 2.86 | W/°C |
| TJ, T _{STG} | Operating and Storage Temperature Range | | –55 to +150 | °C |
| TL | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 s | | 300 | °C |

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, Unless otherwise specified)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. L = 1.4 mH, $I_{AS} = 52 \text{ A}$, $V_{DD} = 50 \text{ V}$, $R_G = 25 \Omega$, starting $T_J = 25^{\circ}\text{C}$. 3. $I_{SD} \le 52 \text{ A}$, di/dt $\le 200 \text{ A/}\mu\text{s}$, $V_{DD} \le \text{BV}_{DSS}$, starting $T_J = 25^{\circ}\text{C}$. 4. Essentially independent of operating temperature typical characteristics.

THERMAL CHARACTERISTICS

| Symbol | Parameter | Value | Unit |
|---------------------|---|-------|------|
| $R_{	ext{	heta}JC}$ | Thermal Resistance, Junction to Case, Max. | 0.35 | °C/W |
| $R_{	hetaJA}$ | Thermal Resistance, Junction to Ambient, Max. | 62.5 | |

PACKAGE MARKING AND ORDERING INFORMATION

| Part Number Top Marking | | Package | Packing Method | Reel Size | Tape Width | Quantity | |
|-------------------------|----------|---------|----------------|-----------|------------|----------|--|
| FDP52N20 | FDP52N20 | TO-220 | Tube | N/A | N/A | 50 Units | |

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Unit |
|--|--|--|-----|-------|-------|------|
| OFF CHARACT | ERISTICS | - | | | | - |
| BV _{DSS} | Drain to Source Breakdown Voltage | V_{GS} = 0 V, I_{D} = 250 $\mu A,~T_{J}$ = 25 $^{\circ}C$ | 200 | - | - | V |
| $\Delta \text{BV}_{\text{DSS}} / \Delta \text{T}_{\text{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 µA, Referenced to 25°C | - | 0.2 | _ | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V_{DS} = 200 V, V_{GS} = 0 V | - | - | 1 | μΑ |
| | | V_{DS} = 160 V, T_{C} = 125°C | - | - | 10 | |
| I _{GSS} | Gate to Body Leakage Current | V_{GS} = ±30 V, V_{DS} = 0 V | - | - | ±100 | nA |
| ON CHARACTE | RISTICS | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \ \mu A$ | 3.0 | - | 5.0 | V |
| R _{DS(on)} | Static Drain to Source On Resistance | V _{GS} = 10 V, I _D = 26 A | - | 0.041 | 0.049 | Ω |
| 9 _{FS} | Forward Transconductance | V _{DS} = 40 V, I _D = 26 A | - | 35 | - | S |
| YNAMIC CHA | RACTERISTICS | | | | | |
| C _{iss} | Input Capacitance | V_{DS} = 25 V, V_{GS} = 0 V, f = 1 MHz | - | 2230 | 2900 | pF |
| C _{oss} | Output Capacitance | | _ | 540 | 700 | pF |
| C _{rss} | Reverse Transfer Capacitance | | - | 66 | 100 | pF |
| Q _{g(tot)} | Total Gate Charge at 10 V | V _{DS} = 160 V, I _D = 52 A, V _{GS} = 10 V (Note 5) | - | 49 | 63 | nC |
| Q _{gs} | Gate to Source Gate Charge | | - | 19 | - | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | | _ | 24 | - | nC |
| WITCHING CH | IARACTERISTICS | - | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 100 \text{ V}, \text{ I}_{D} = 20 \text{ A},$ | - | 53 | 115 | ns |
| t _r | Turn-On Rise Time | R _G = 25 Ω (Note 5) | - | 175 | 359 | ns |
| t _{d(off)} | Turn-Off Delay Time | | - | 48 | 107 | ns |
| t _f | Turn-Off Fall Time | | _ | 29 | 68 | ns |
| RAIN-SOURC | E DIODE CHARACTERISTICS | • | | | | |
| I _S | Maximum Continuous Drain to Source Diode Forward Current | | - | - | 52 | Α |
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | - | - | 204 | Α |
| V_{SD} | Drain to Source Diode Forward Voltage | V_{GS} = 0 V, I _{SD} = 52 A | - | - | 1.5 | V |
| t _{rr} | Reverse Recovery Time | $V_{GS} = 0 V, I_{SD} = 52 A,$ | - | 162 | - | ns |
| Qrr | Reverse Recovery Charge | dl _F /dt = 100 Å/μs | _ | 1.3 | _ | uC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.5. Essentially independent of operating temperature typical characteristics.

1.3

μC

Reverse Recovery Charge

 Q_{rr}

TYPICAL PERFORMANCE CHARACTERISTICS

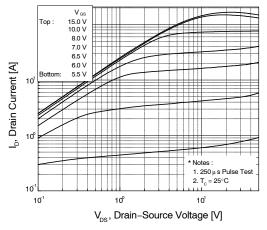


Figure 1. On-Region Characteristics

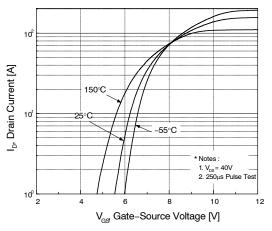


Figure 2. Transfer Characteristics

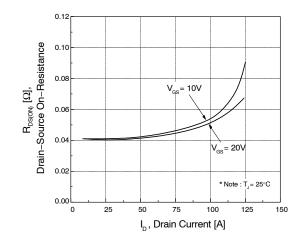


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

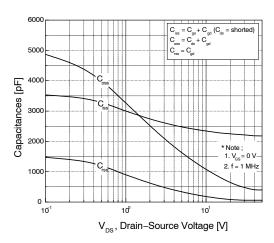


Figure 5. Capacitance Characteristics

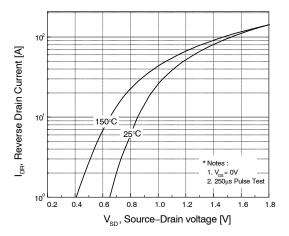


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

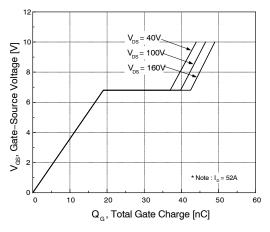


Figure 6. Gate Charge Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS

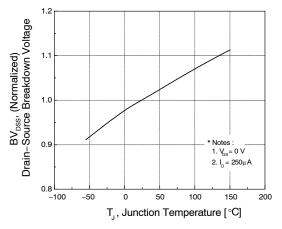


Figure 7. Breakdown Voltage Variation vs. Temperature

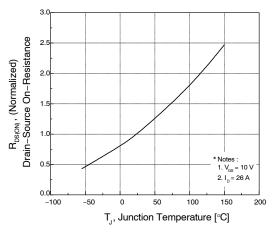


Figure 8. On-Resistance Variation vs. Temperature

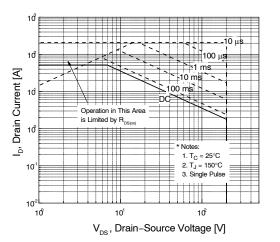


Figure 9. Maximum Safe Operation Area

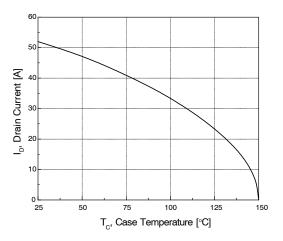


Figure 10. Maximum Drain Current

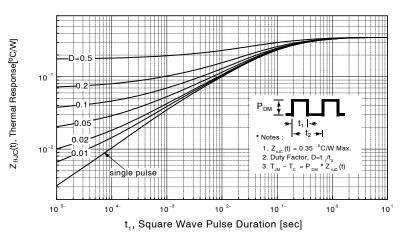


Figure 11. Transient Thermal Response Curve

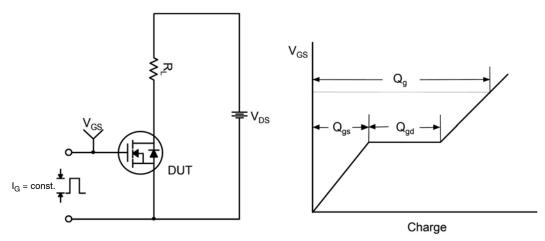


Figure 12. Gate Charge Test Circuit & Waveform

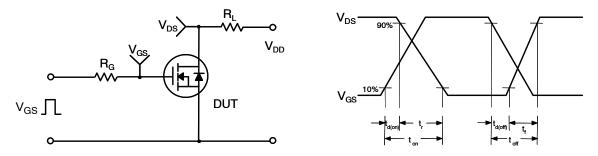


Figure 13. Resistive Switching Test Circuit & Waveforms

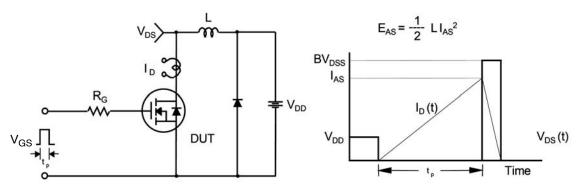
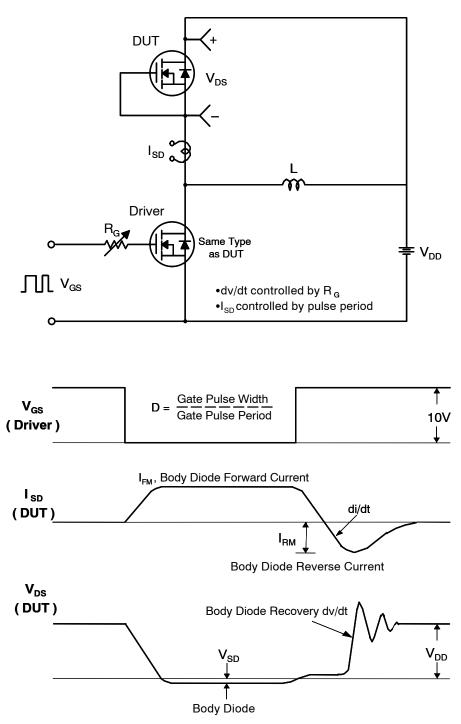
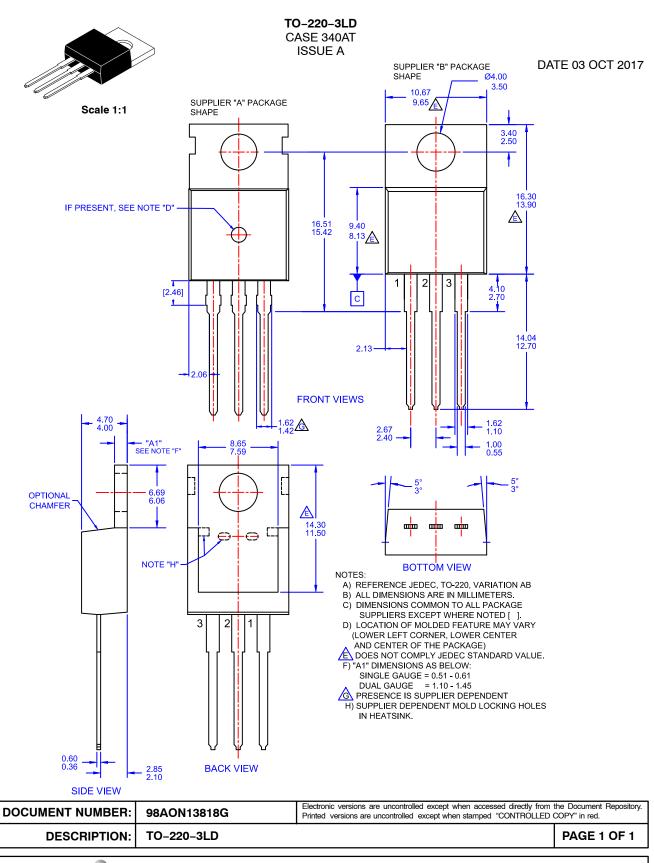


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms









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